

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10589044	NISHIKAWA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Christopher L Chin	1641

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST search	1/31/10	CC
EAST search	6/20/10	CC

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
Same as above		8/11/10	CC

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